

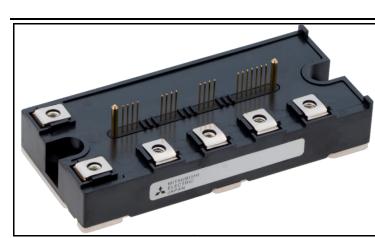


<Intelligent Power Modules>

PM75CGB120

FLAT-BASE TYPE INSULATED PACKAGE

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(Date)		8 th -Oct. 2015	

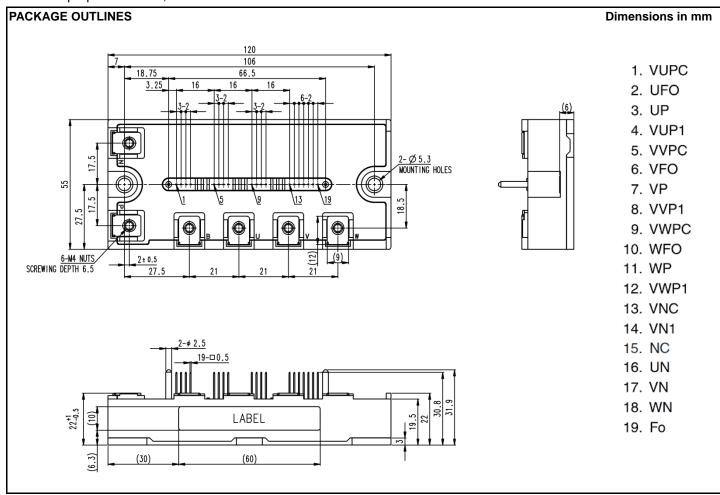


FEATURE

- a) Adopting Full-Gate CSTBT[™] chip.
- b) The over-temperature protection which detects the chip surface temperature of $\mathsf{CSTBT}^\mathsf{TM}$ is adopted.
- c) Error output signal is possible from all each protection upper and lower arm of IPM.

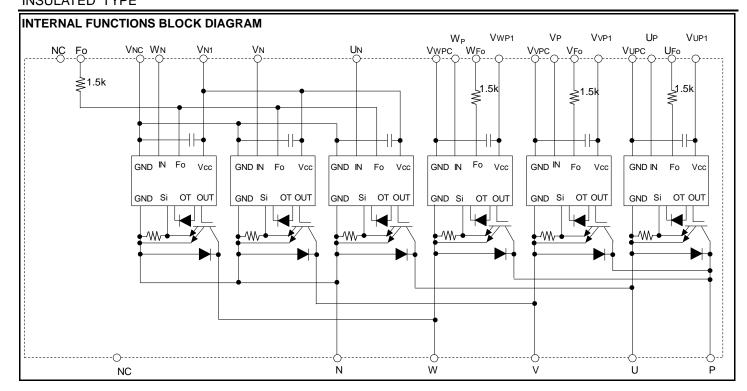
APPLICATION

General purpose inverter, servo drives and other motor controls



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MAXIMUM RATINGS (T_i = 25°C, unless otherwise noted)

INVERTER PART

Symbol	Parameter	Conditions	Ratings	Unit
V _{CES}	Collector-Emitter Voltage	V _D =15 V, V _{CIN} =15 V	1200	V
I _C	Collector Current	T _C =25 °C	75	۸
I _{CRM}	Collector Current	Pulse	150	Α
P _{tot}	Total Power Dissipation	T _C =25 °C	543	W
IE	Emitter Current	T _C =25 °C	75	۸
I _{ERM}	(Free-wheeling Diode Forward current)	Pulse	150	Α
T _j	Junction Temperature		-20 ~ +150	°C

^{*:} Tc measurement point is just under the chip.

CONTROL PART

Symbol	Parameter	Conditions	Ratings	Unit
V_D	Supply Voltage	Applied between: V _{UP1} -V _{UPC} , V _{VP1} -V _{VPC} , V _{WP1} -V _{WPC} , V _{N1} -V _{NC}	20	V
V_{CIN}	Input Voltage	Applied between: U _P -V _{UPC} , V _P -V _{VPC} , W _P -V _{WPC} , U _N , V _N , W _N -V _{NC}	20	V
V_{FO}	Fault Output Supply Voltage	Applied between: U _{FO} -V _{UPC} , V _{FO} -V _{VPC} , W _{FO} -V _{WPC} , Fo-V _{NC}	20	V
I _{FO}	Fault Output Current	Sink current at U _{FO} , V _{FO} , W _{FO} , Fo terminals	20	mA

TOTAL SYSTEM

Symbol	Parameter	Conditions	Ratings	Unit
V _{CC(PROT)}	Supply Voltage Protected by SC	V _D =13.5 V~16.5 V, Inverter Part, T _j =+125°C start	800	V
V _{CC(surge)}	Supply Voltage (Surge)	Applied between: P-N, Surge value	1000	V
T _{stg}	Storage Temperature	-	-40 ~ +125	°C
V _{isol}	Isolation Voltage	60Hz, Sinusoidal, Charged part to Base plate, AC 1min, RMS	2500	V

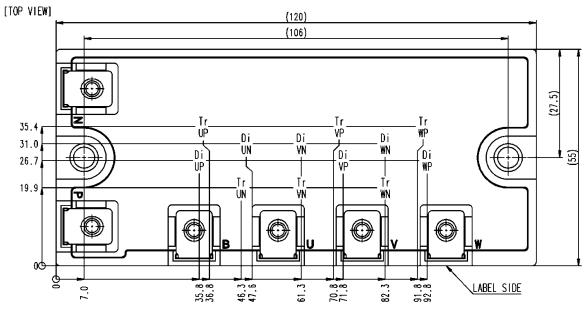
^{*:} Tc measurement point is just under the chip.



THERMAL RESISTANCE

Symbol	Parameter	Conditions	Limits			Unit
		Conditions		Тур.	Max.	Offic
$R_{th(j-c)Q}$	Thermal Resistance	Junction to case, IGBT, per 1 element (Note1)	-	-	0.23	
$R_{th(j-c)D}$		Junction to case, FWD, per 1 element (Note1)	-	-	0.37	K/W
R _{th(c-s)}	Contact Thermal Resistance	Case to heat sink, per 1 module,	- 0	0.022	-	
		Thermal grease applied (Note.1)				

Note1. If you use this value, $R_{\text{th(s-a)}}$ should be measured just under the chips.



ELECTRICAL CHARACTERISTICS (T_j= 25°C, unless otherwise noted)

INVERTER PART

Symbol	Parameter	Conditions		Limits			Unit
Symbol	Parameter			Min.	Тур.	Max.	Offic
\/	CEsat Collector-Emitter Saturation Voltage	V _D =15 V, I _C =75 A	T _j =25 °C	-	1.65	2.15	V
V CEsat		V _{CIN} =0 V, Pulsed, Terminal (Fig.1)	T _j =125 °C	-	1.85	2.35	V
V _{EC}	Emitter-Collector Voltage	I_E =75 A, V_D =15 V, V_{CIN} = 15 V, Terminal (Fig.2)	-	2.05	3.05	V
ton	Switching Time	$V_D=15 \text{ V}, V_{CIN}=0 \text{ V} \longleftrightarrow 15 \text{ V},$		-	0.6	1	
t _{rr}		$V_{\rm CC}$ =600 V, $I_{\rm C}$ =75A, $T_{\rm j}$ =125 °C, Inductive Load		-	0.2	-	
t _{c(on)}				-	0.2	-	μs
t _{off}				-	1.1	-	
t _{c(off)}		(Fig.3, 4)		-	0.4	-	
I _{CES} Collecte	Collector-Emitter Cut-off Current	$V_{CE}=V_{CES}$, $V_{D}=15$ V, $V_{CIN}=15$ V (Fig.5)	T _j =25 °C	-	-	1	mA
	Collector-Emitter Cut-off Current		T _j =125 °C	_	-	10	IIIA

HIGH POWER SWITCHING USE

INSULATED TYPE



ELECTRICAL CHARACTERISTICS (cont.; T_j = 25°C, unless otherwise noted)

CONTROL PART

Comple ed	Davarantas	Conditions		Limits			l lait
Symbol	Parameter	Conditions	Conditions		Тур.	Max.	Unit
Circuit Current	Circuit Current	$V_{D}=15 \text{ V}, V_{CIN}=15 \text{ V}$	V _{P1} -V _{PC}	-	2	4	
ID	Circuit Current		V _{N1} -V _{NC}	-	6	12	mA
$V_{th(ON)}$	Input ON Threshold Voltage	Applied between:		1.2	1.5	1.8	V
$V_{th(OFF)}$	Input OFF Threshold Voltage	$U_P\text{-}V_UPC,V_P\text{-}V_VPC,W_P\text{-}V_WPC,U_N,V_N,W_N\text{-}V_NC$		1.7	2.0	2.3	V
SC	Short Circuit Trip Level	-20≤T _j ≤125 °C, V _D =15 V (Fig.3, 6)		150	-	-	Α
t _{off(SC)}	Short Circuit Current Delay Time	V _D =15 V (Fig.3, 6)		-	0.2	-	μs
ОТ	Over Temperature Protection	Detect Temperature of IGBT chip	Trip level	150	-	-	°C
OT _(hys)	Over Temperature Protection		Hysteresis	-	20	-	
UVt	Supply Circuit	20<7 <425 °C	Trip level	11.5	12.0	12.5	V
UVr	Under-Voltage Protection	-20≤T _j ≤125 °C	Reset level	-	12.5	-	V
I _{FO(H)}	Foult Output Current	\\ 45\\\\ 45\\\\\\\\\\\\\\\\\\\\\\\\\\\		-	-	0.01	A
I _{FO(L)}	Fault Output Current	V _D =15 V, V _{FO} =15 V (Note2)		-	10	15	mA
t _{FO}	Fault Output Pulse Width	V _D =15 V (Note2)		1.0	1.8	-	ms

Note2. Fault output is given only when the internal SC, OT & UV protections schemes of either upper or lower arm device operate to protect it.

MECHANICAL RATINGS AND CHARACTERISTICS

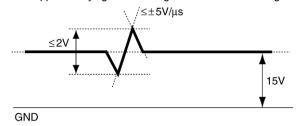
Symbol	Parameter	Conditions		Limits		
				Тур.	Max.	Unit
Ms	Mounting Torque	Mounting part screw : M5	2.5	3.0	3.5	N•m
M_t	Mounting Torque	Main terminal part screw : M4	1.5	1.7	2.0	N•m
m	mass	-	-	320	-	g

RECOMMENDED CONDITIONS FOR USE

Symbol	Parameter	Conditions	Recommended value	Unit
V_{CC}	Supply Voltage	Applied across P-N terminals	≤ 800	٧
V _D	Control Supply Voltage	Applied between: V _{UP1} -V _{UPC} , V _{VP1} -V _{VPC} , V _{WP1} -V _{WPC} , V _{N1} -V _{NC} (Note3)	15.0±1.5	٧
V _{CIN(ON)}	Input ON Voltage	Applied between :	≤ 0.8	V
V _{CIN(OFF)}	Input OFF Voltage	$U_{P}\text{-}V_{UPC},V_{P}\text{-}V_{VPC},W_{P}\text{-}V_{WPC},U_{N},V_{N},W_{N}\text{-}V_{NC}$	≥ 9.0	v
f _{PWM}	PWM Input Frequency	Using Application Circuit of Fig. 8	≤ 20	kHz
t _{dead}	Dead Time	For IPM's each input signals (Fig.7)	≥ 2.5	μs

This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU.

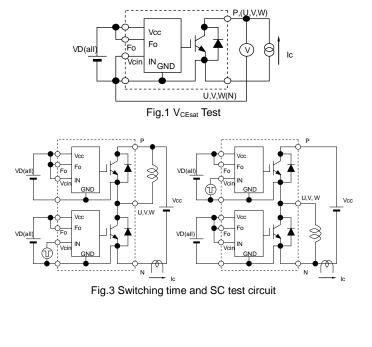
Note3. With ripple satisfying the following conditions: dv/dt swing $\leq \pm 5$ $V/\mu s$, Variation ≤ 2 V peak to peak



PRECAUTIONS FOR TESTING

- 1. Before applying any control supply voltage (V_D), the input terminals should be pulled up by resistors, etc. to their corresponding supply voltage and each input signal should be kept off state.
 - After this, the specified ON and OFF level setting for each input signal should be done.
- 2. When performing "SC" tests, the turn-off surge voltage spike at the corresponding protection operation should not be allowed to rise above V_{CES} rating of the device.

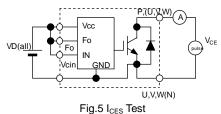
(These test should not be done by using a curve tracer or its equivalent.)



U,V,W(N) Fig.2 V_{EC} Test

90% 90% 10% 10% tc(off tc(on) Vcin td(on)

Fig.4 Switching time test waveform



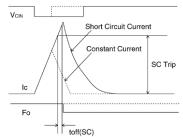
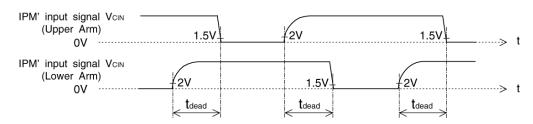
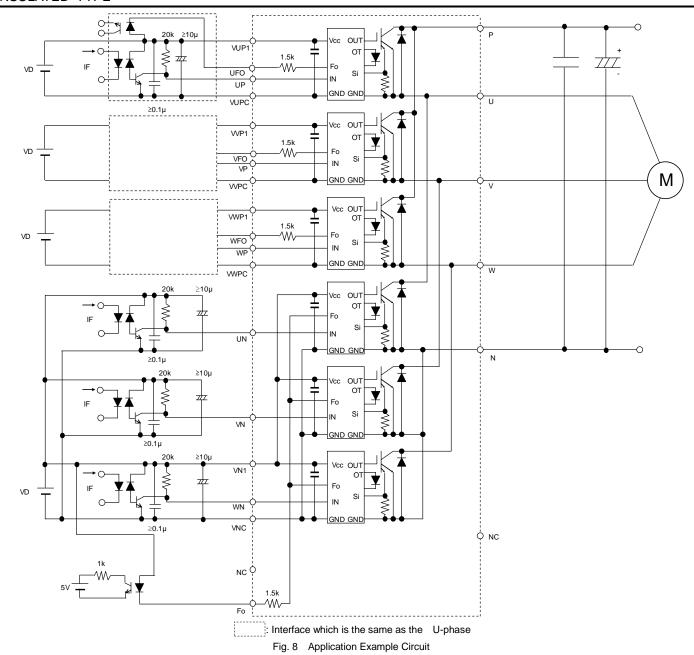


Fig.6 SC test waveform



1.5V: Input on threshold voltage Vth(on) typical value, 2V: Input off threshold voltage Vth(off) typical value Fig. 7 Dead time measurement point example





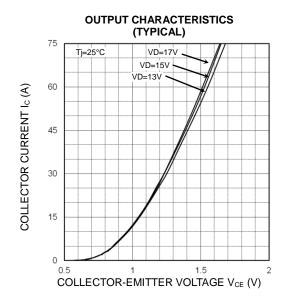
NOTES FOR STABLE AND SAFE OPERATION;

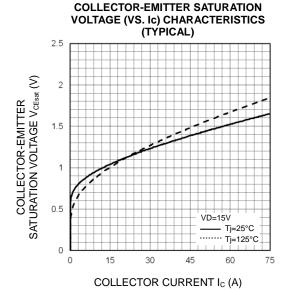
- Design the PCB pattern to minimize wiring length between opto-coupler and IPM's input terminal, and also to minimize the stray capacity between the input and output wirings of opto-coupler.
- Connect low impedance capacitor between the Vcc and GND terminal of each fast switching opto-coupler.
- Fast switching opto-couplers: t_{PLH}, t_{PHL} ≤ 0.8µs, Use High CMR type.
- Slow switching opto-coupler: CTR > 100%
- Use 4 isolated control power supplies (V_D). Also, care should be taken to minimize the instantaneous voltage charge of the power supply.
- Make inductance of DC bus line as small as possible, and minimize surge voltage using snubber capacitor between P and N terminal.

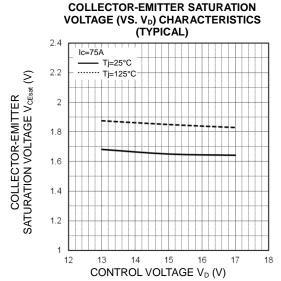
INSULATED TYPE

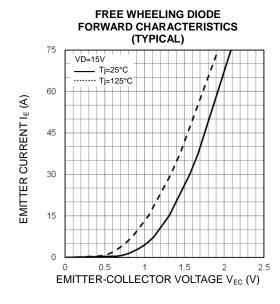
PERFORMANCE CURVES

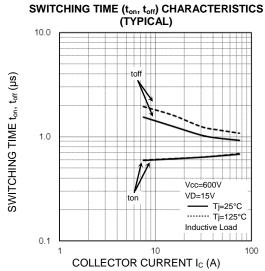


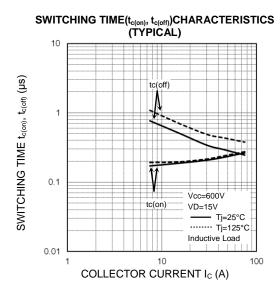








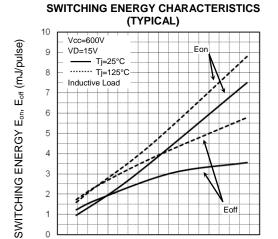




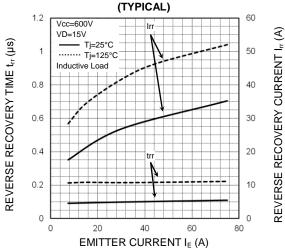
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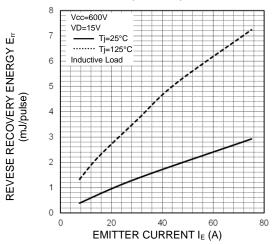


FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL) Vcc=600V VD=15V

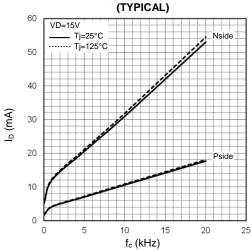




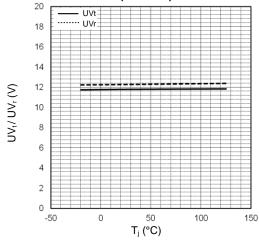
COLLECTOR CURRENT Ic (A)



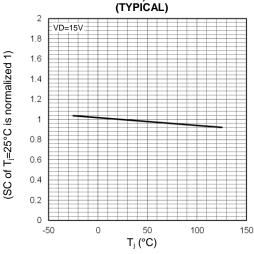
ID VS. fc CHARACTERISTICS



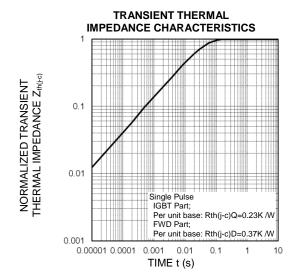
UV TRIP LEVEL VS. T; CHARACTERISTICS (TYPICAL)



SC TRIP LEVEL VS. T; CHARACTERISTICS









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